


<b>Search Notes</b>  	<b>Application/Control No.</b>  10572839	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA, HIDEO
	<b>Examiner</b>  RICHARD H KIM	<b>Art Unit</b>  2871

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East Text Search (349/113,114)	3/31/08	RHK

INTERFERENCE SEARCH			
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